Class B Certification Application

Under Part 15, Subpart B

EUT Mainboard

MODEL A815EP

FCC ID PRB-MB-A815EP-11

SRT REPORT # FID1D036

PREPARED FOR

ZIDA TECHNOLOGIES LTD.

8/F, BLOCK A, GOODVIEW INDUSTRIAL BUILDING, 11 KIN FAT STREET, TUEN MUN, HONG KONG

ZIDA TECHNOLOGIES LTD.

8/F, BLOCK A, GOODVIEW INDUSTRIAL BUILDING, 11 KIN FAT STREET, TUEN NUM, HONG KONG TEL: 852-22766349 FAX: 852-24560717

Federal Communications Commission Authorization and Evaluation Division 7435 Oakland Mills Road Columbia, MD 21046

To whom it may concern:

This is to serve as proper written authorization that Spectrum Research and Testing Laboratory, Inc., 15200, Shady Grove Rd., Rockville, MD. 20850, will act as our representative in all matters relating to FCC applications for equipment approval. This includes the signing of all related documents, the transmitting of required fees, and receiving correspondence and notifications from the FCC. All acts performed by Spectrum Research and Testing Laboratory, Inc., especially modifications to our equipment under testing will be carried out on our behalf.

Meantime, the applicant certifies that in the case of an individual applicant (e.g., corporation), no party to the applicant is subject to a denial of federal benefits, that includes FCC benefits, pursuant to Section 5301 of the Anti-Drug Abuse Act of 1998,21 U.S.C. 862. For a definition of a "party " for these purposes see 47 C.F.R. 1.2002 (b).

If you have any questions regarding our applications for equipment approval, please contact Spectrum Research and Testing Laboratory, Inc. by calling (301) 670-2818.

Respectfully,

(Name, Surname)

Effective Dates:

RO MANASEP (Position/Title) From May debles 31 May 200/

DATE: 8 MAY 2001





EMI TESTING REPORT

EUT : Mainboard

MODEL : A815EP

FCC ID : PRB-MB-A815EP-11

PREPARED FOR

ZIDA TECHNOLOGIES LTD.

8/F, BLOCK A, GOODVIEW INDUSTRIAL BUILDING,

11 KIN FAT STREET, TUEN MUN,

HONG KONG

PREPARED BY

SPECTRUM RESEARCH & TESTING LABORATORY INC. NO. 101-10, LING 8, SHAN-TONG LI CHUNG – LI CITY,

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1. TEST REPORT CERTIFICATION

APPLICANT	ZIDA TECHNOLOGIES LTD.
ADDRESS	8/F, BLOCK A, GOODVIEW INDUSTRIAL BUILDING,
122222	11 KIN FAT STREET, TUEN MUN,
	HONG KONG
EUT DESCRIPTI	ON Mainboard
(A) POWER SU	
(B) MODEL	A815EP
(C) FCC ID	PRB-MB-A815EP-11
FINAL TEST DA	ATE 05/22/2001

MEASUREMENT PROCEDURE USED

- * PART 15 SUBPART B OF FCC RULES AND REGULATIONS ($47\ \text{CFR}$ PART 15)
- * ANSI C63.4 1992
- * TEST PROCEDURE AND DATA ARE TRACEABLE TO NATIONAL OR INTERNATIONAL STANDARDS.

We hereby certify that

The measurements contained in this report were made in accordance with the procedures indicated, and the energy emitted by the equipment was found to be within the limits applicable.

TESTING ENGINEER	-	DATE
	Page Liu	
SUPERVISOR		DATE
	Sunyou Chen	
APPROVED BY		DATE
	Johnson Ho	





2. TEST STATEMENT

2.1 TEST STATEMENT

- 1. This statement is to explain the test condition of this project. The EUT was the test condition of each test item.
- 2. The data was shown in this report reflects the worst case data for the condition as the summary of test result.
- 3. EUT conditions.

PC CPU: Intel Pentium III 933MHz, clock chip: 133MHz **Resolution:** 640 * 480

4. NVLAP logo is to be approved by management (it is according to NVLAP requirement if it need) before use.

2.2 DEPARTURE FROM DOCUMENT POLICIES, PROCEDURE OR SPECIFICATIONS, THE STATEMNT

•	from	document	policies	&	procedures	or	from
Yes	, lescripti	No on as bel	ow.				

- 2. The certificate and report shall not be reproduced except in full, without the written approval of SRT laboratory.
- 3. The report must not be used by the client to claim product endorsement by NVLAP or any agency the government.
- 4. This product is a test sample that was shown as the photos of this test report only.
- 5. The effect that the results relate only to the items tested.





3. EUT MODIFICATIONS

The following accessories were added to the EUT during testing

- 1). Replaced RN29, RN30 and RN31 by bead (MLB-3216-0030M4-N2).
- 2). Replaced R263, R264, R265, R266, R98 and R91 by bead (MLB-160808-0030A-N2).
- 3). Replaced C6 ~ C29 by 47pF capacitor.
- 4). To series a bead (MLB-160808-0030A-N2) at Pin23 and Pin24 of U2.
- 5). To series a bead (MLB-160808-0600B-N3) at Pin2, Pin3 of Q22 and Pin1, Pin9, Pin10, Pin18, Pin25 of U2 and Pin2, Pin3 of Q20.
- 6). Added a core (A5 FP 63.5*6.35*10) at IDE cable.
- 7). To shield ATX power cable.





ZIDA TECHNOLOGIES LTD.

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Federal Communications Commission Authorization and Evaluation Division 7435 Oakland Mills Road Columbia, MD 21046

To whom it may concern:

This is to serve as proper notice that our company agrees to make all modifications to FCC ID: PRB-MB-A815EP-11 as listed in section 3.0 of modification to submitted by Spectrum Research and Testing Laboratory, Inc.

Respectfully,

(Name, Surname)

Effective Dates:

From 1 May deciso 31 May dro 1

(Position/Title)

DATE: 8 MAY 2001





4. CONDUCTED POWER LINE TEST

4.1 TEST EQUIPMENT

The following test equipment were used during the conducted power line test

EQUIPMENT/ FACILITIES	SPECIFICATIONS	MANUFACTURER	MODEL#/ SERIAL#	DATE OF CAL. & CAL. CENTER	DUE DATE	FINAL TEST
EMI TEST	9 KHz TO 30	ROHDE &	ESHS30/	MARCH 2001	1Y	
RECEIVER	MHz	SCHWARZ	826003/008	R & S		
EMI TEST	9 KHz TO 2750	ROHDE &	ESCS30/	JULY 2000	1 Y	al.
RECEIVER	MHz	SCHWARZ	830245/012	ETC		V
LISN	50 uH, 50 ohm	SOLAR	9252-50-	JULY 2000	1Y	
		ELECTRONICS	R-24-BNC/	ETC		\checkmark
			951315			
LISN	50uH, 50 ohm	SOLAR	9252-50-	JULY 2000	1Y	
		ELECTRONICS	R-24-BNC/	ETC		\checkmark
			951318			
SIGNAL	9 KHz TO 1080	ROHDE &	SMY01/	MARCH 2001	1 Y	V
GENERATOR	MHz	SCHWARZ	841104/019	ETC		V
POWER	50 TO 300 VAC	AFC	AFC-2KBB/	APRIL 2001	1Y	2/
CONVERTER	47 TO 63/50/60Hz		F100030030	SRT		V

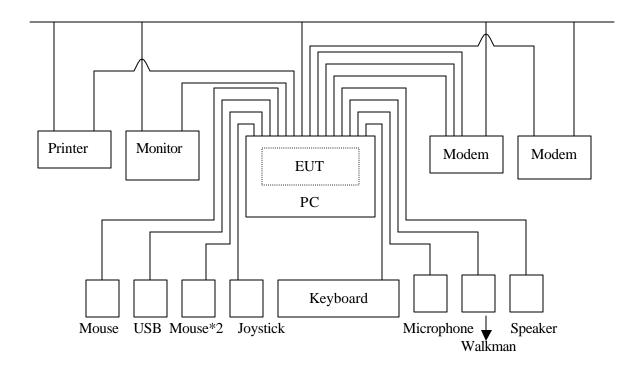
4.2 TEST PROCEDURE

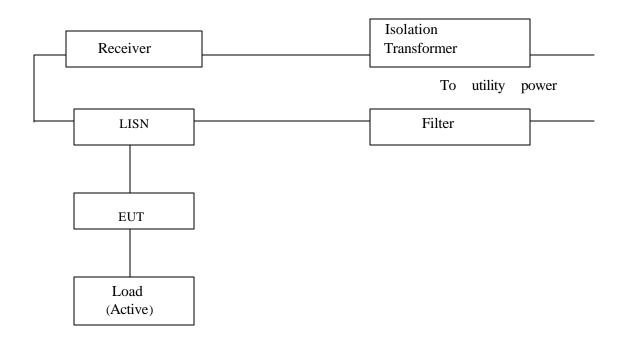
The EUT was tested according to ANSI C63.4 - 1992. The frequency spectrum from <u>0.45</u> MHz to <u>30</u> MHz was investigated. The LISN used was 50 ohm / 50 uHenry as specified by section 5.1 of ANSI C63.4 - 1992. Cables and peripherals were moved to find the maximum emission levels for each frequency.





4.3 TEST SETUP









4.4 CONFIGURATION OF THE EUT

The EUT was configured according to ANSI C63.4 - 1992. All interface ports were connected to the appropriate peripherals. All peripherals and cables are listed below.

1. EUT

DEVICE	MANUFACTURER	MODEL #	FCCID
Mainboard	ZIDA TECHNOLOGIES	A815EP	PRB-MB-A815EP-11
	LTD.		

2. INTERNAL DEVICES

DEVICE	MANUFACTURER	MODEL #	FCCID/DoC
N/A			





3. PERIPHERALS

DEVICE	MANUFAC	MODEL #	FCCID /	CABLE
	TURER	SERIAL #	DoC	
MONITOR	SAMSUNG	700IFT	DoC	1.5m unshielded power cord
				1.2m shielded data cable (S2)
PRINTER	HP	2225C+	DSI6XU2225	1.5m unshielded power cord
				1.2m shielded data cable (S2)
MODEM	SMARTEAM	103/212A	EF56A5103/212A	1.5m unshielded power cord
				1.2m shielded data cable (S2)
MODEM	SMARTEAM	103/212A	EF56A5103/212A	1.5m unshielded power cord
				1.2m shielded data cable (S2)
MOUSE	HP	M-S34	DZL210472	1.5m unshielded data cable
USB MOUSE	ALLSPIRIT	TUN2	DoC	1.5m unshielded data cable
USB MOUSE	ALLSPIRIT	TUN2	DoC	1.5m unshielded data cable
KEYBOARD	COMPAQ	286241-AB5	AQ6-71Z15	1.2m unshielded data cable
SPEAKER	JUSTER	JB-599	N/A	1.2m unshielded data cable
MICRO-	TAKY	UDM-606	N/A	1.5m unshielded data cable
PHONE				
WALKMAN	CURTIS	FT-28	N/A	1.2m unshielded data cable
JOYSTICK	LOGITECH	J-YG8	DoC	1.5m unshielded data cable
POWER	MERIDIAN	CWT-200AT	DoC	N/A
SUPPLY		X(SFX)		
HDD	QUAMTUM	FIREBALL	DoC	N/A
		EX6.4A		
FDD	PANASONIC	JU-257A606P	N/A	N/A
CD ROM	TEAC	CD-532E	N/A	N/A
VGA CARD	MSI	MS-8801	DoC	N/A

REMARK

- Single point shielding. 1. Cable S1
 - 360 shielding. **S**2
 - Double point shielding **S**3
- 2. Cables -All 1m or greater in length - bundled according to regulations.





4.5 EUT OPERATING CONDITION

Operating condition is according to ANSI C63.4 - 1992.

- 1. EUT power on.
- 2. Under WIN 98 run "EMI TEST" program.
 - " H" pattern sent to the following peripherals
 - Monitor or VGA
 - RS232 (modem)
 - Keyboard
 - Printer
 - FDD
 - HDD
- 3. CPU: Inter Pentium III 933MHz, clock chip: 133MHz
- 4. Resolution: 640*480

4.6 CONDUCTED POWER LINE EMISSION LIMIT

FREQUENCY RANGE (MHz)	CLASS A	CLASS B
0 . 45 - 1.705	60.0dBμV	48.0dBμV
1.705 - 30	69.5dBµV	48.0dBμV

NOTE In the above table, the tighter limit applies at the band edges.





4.7 CONDUCTED POWER LINE TEST RESULTS

The frequency spectrum from <u>0.45</u> MHz to <u>30</u> MHz was investigated. All readinges are quasi - peak values with a resolution bandwidth of 9 KHz.

Temperature 56 %RH Humidity Test result

FREQUENCY (MHz)	LINE1 (dBuV)	LINE2 (dBuV)	LIMIT (dBuV)
0.61	41.4	41.0	48.0
0.77	42.9	*	48.0
0.92	*	41.5	48.0
2.00	40.3	40.4	48.0
9.13	35.1	*	48.0
22.83	38.0	40.8	48.0

REMARKS

- 1. * = Measurement does not apply for this frequency
- 2. Uncertainty in conducted emission measured is <+/ -2dB
- 3. Any departure from specification N/A

SIGNED BY TESTING ENGINEER





5. RADIATED EMISSION TEST

5.1 TEST EQUIPMENT

The following test equipment were used during the radiated emission test

EQIPMENT /	SPECIFICA-	MANUFACTUR	MODEL # /	DATE OF CAL.	DUE	FINAL
FACILITIES	TIONS	- ER	SERIAL #	& CAL. CENTER	DATE	TEST
TEST	9 KHz TO	R & S	ESCS30/	JULY 2000	1 Y	√
RECEIVER	2.75 MHz		830245/012	ETC		
TEST	20 MHz TO	R & S	ESVS30/	JULY 2000	1 Y	\checkmark
RECEIVER	1000 MHz		841977/003	ETC		
SPECTRUM	100 Hz TO	HP	8568B/	AUG. 2000	1Y	
ANALYZER	1500 MHz		3001A04931	ETC		
SPECTRUM	9 KHz TO	HP	8593E/	MARCH 2001	1Y	
ANALYZER	22 GHz		3322A00670	ETC		
SIGNAL	9 KHz TO	ROHDE &	SMY01/	MARCH 2001	1 Y	\checkmark
GENERATOR	1080 MHz	SCHWARZ	841104/019	ETC		
DIPOLE	28 MHz TO	EMCO	3121C/	FEB. 2001	1Y	
ANTENNA	1000 MHz		9003-534	SRT		
DIPOLE	28 MHz TO	EMCO	3121C/	FEB. 2001	1Y	
ANTENNA	1000 MHz		9611-1239	SRT		
BI-LOG	26 MHz TO	EMCO	3142/	NOV. 2000	1Y	\checkmark
ANTENNA	2000 MHz		9701-1124	SRT		
BI-LOG	26 MHz TO	EMCO	3142/	SET. 2000	1 Y	
ANTENNA	2000 MHz		9608-1073	SRT		
BI-LOG	26 MHz TO	EMCO	3143/	AUG. 2000	1Y	
ANTENNA	1100 MHz		9509-1152	SRT		
PRE-AMPLIFIER	0.1 MHz TO	HP	8447D/	MARCH 2001	1 Y	
	1300 MHz		2944A08402	SRT		
PRE-AMPLIFIER	0.1 MHz TO	HP	8447D/	AUG. 2000	1 Y	
	1300 MHz		2944A06412	ETC		
HORN	1 GHz TO	EMCO	3115/	JAN. 2001	1 Y	\checkmark
ANTENNA	18 GHz		9012-3619	ETC		

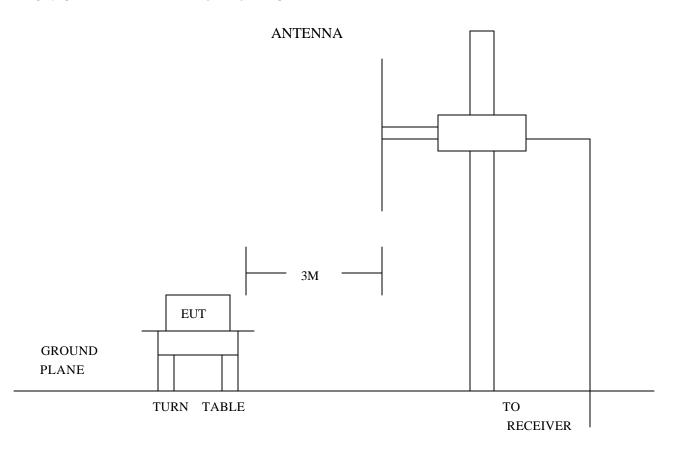




5.2 TEST PROCEDURE

- 1. The EUT was tested according to ANSI C63.4 1992. The radiated test was performed at SRT lab's open site. This site is on file with the FCC laboratory division, reference 31040/SIT.
- 2. The EUT, peripherals were put on the turntable which table size is 1m x 1.5 m, table high <u>0.8</u> m. All set up is according to ANSI C63.4-1992.
- 3. The frequency spectrum from 30 MHz to 1 GHz was investigated. All readings from 30 MHz to 1 GHz are quasi-peak values with a resolution bandwidth of 120 KHz. All readings are above 1 GHz, peak values with a resolution bandwidth of 1 MHz. Measurements were made at <u>3</u> meters.
- 4. The antenna high were varied from 1 m to 4 m high to find the maximum emission for each frequency.
- 5. The antenna polarization Vertical polarization and horizontal polarization.

5.3 RADIATED TEST SET-UP

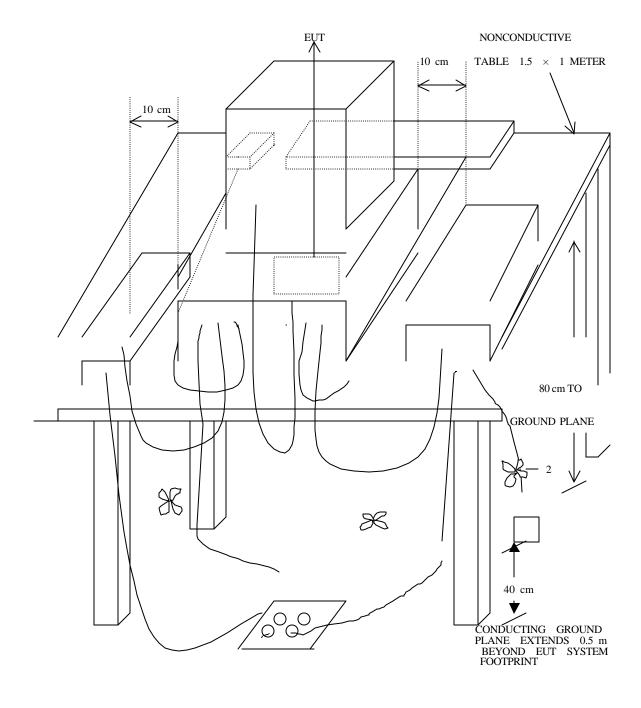






5.3 RADIATED TEST SET-UP

ANSI C63.4-1992







5.4 CONFIGURATION OF THE THE EUT

Same as section 4.4 of this report

5.5 EUT OPERATING CONDITION

Same as section 4.5 of this report.

5.6 RADIATED EMISSION LIMITS

All emission from a digital device, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strength specified below

CLASS B

FREQUENCY (MHz)	DISTANCE (m)	FIELD STRENGTH (dBmV/m)
30 - 88	3	40.0
88 - 216	3	43.5
216 - 960	3	46.0
ABOVE 960	3	54.0

CLASS B (OPEN CASE)

FREQUENCY (MHz)	DISTANCE (m)	FIELD STRENGTH (dBmV/m)
30 - 88	3	46.0
88 - 216	3	49.5
216 - 960	3	52.0
ABOVE 960	3	60.0

CLASS A

FREQUENCY (MHz)	DISTANCE (m)	FIELS STRENGTH (dBmV/m)
30 - 88	3	50.0
88 - 216	3	53.5
216 - 960	3	56.0
ABOVE 960	3	64.0

NOTE 1. In the emission tables above, the tighter limit applies at the band edges.

2. Distance refers to the distance between measuring instrument,





antemma, and the closest point of any part of the device or system.

5.7 RADIATED EMISSION TEST RESULTS

The frequency spectrum from 30 MHz to 10 GHz was investigated. All readings from 30 MHz to 1 GHz are quasi-peak values with a resolution bandwidth of 120 KHz. All readings are above <u>1</u> GHz, peak values with a resolution bandwidth of <u>1</u> MHz. Measurements were made at <u>3</u> meters.

Temperature 60 %RH Humidity Test result

FREQ.		ANT. FACTOR	READING (dB m V)		EMISSION (dBmV/m)		LIMITS
(MHz)	(dB)	(dB/m)	HORIZ	VERT	HORIZ	VERT	(dBmV/m)
132.5145	1.7	13.1	20.5	21.3	35.3	36.1	43.5
166.4389	1.9	11.8	22.1	23.0	35.8	36.7	43.5
147.4750	1.8	12.9	22.6	21.2	37.3	35.9	43.5
172.0550	1.9	11.4	23.2	22.5	36.5	35.8	43.5
669.2510	3.8	20.1	17.3	16.3	41.2	40.2	46.0
794.8160	4.2	21.6	17.6	17.2	43.4	43.0	46.0
1066.0000	3.0	24.8	22.8	23.2	50.6	51.0	54.0
1328.0000	3.4	25.5	18.0	18.2	46.9	47.1	54.0
1591.0000	3.8	26.5	14.5	14.1	44.8	44.4	54.0
1733.0000	3.9	27.2	*	14.3	*	45.4	54.0
1858.0000	4.0	27.8	14.1	13.2	45.9	45.0	54.0
2555.0000	5.2	28.1	17.4	14.3	50.7	47.6	54.0

REMARKS

- 1. *= Measurement does not apply for this frequency.
- 2. Uncertainty in radiated emission measured is <+/-4dB
- 3. Any departure from specification N/A
- 4. Factor will include cable loss and correction factor.
- 5. Sample calculation Emissiom($dB\mu\nu/m$) = Factor (dB) + Ant. Factor (dB/m) + reading $(dB\mu V)$
- 6. Close case





SIGNED BY TESTING ENGINEER

5.7 RADIATED EMISSION TEST RESULTS

The frequency spectrum from 30 MHz to 10 GHz was investigated. All readings from 30 MHz to 1 GHz are quasi-peak values with a resolution bandwidth of 120 KHz. All readings are above <u>1</u> GHz, peak values with a resolution bandwidth of <u>1</u> MHz. Measurements were made at <u>3</u> meters.

Temperature 60 %RH Humidity Test result

FREQ.	FACTOR	ANT. FACTOR	READING (dB m V)		EMISSION (dBmV/m)		LIMITS
(MHz)	(dB)	(dB/m)	HORIZ	VERT	HORIZ	VERT	(dBmV/m)
132.5129	1.7	13.1	30.9	25.3	45.7	40.1	49.5
264.9975	2.3	13.2	25.1	27.8	40.6	43.3	52.0
397.4460	2.7	16.0	26.5	20.2	45.2	38.9	52.0
529.9165	3.2	17.5	28.0	28.6	48.7	49.3	52.0
662.3478	3.8	20.1	22.5	24.8	46.4	48.7	52.0
794.8350	4.2	21.6	23.5	21.2	49.3	47.0	52.0
1066.0000	3.0	24.8	28.8	29.2	56.6	57.0	60.0
1328.0000	3.4	25.5	24.0	24.2	52.9	53.1	60.0
1591.0000	3.8	26.5	20.6	20.2	50.9	50.5	60.0
1733.0000	3.9	27.2	*	20.3	*	51.4	60.0
1858.0000	4.0	27.8	20.1	19.2	51.9	51.0	60.0
2555.0000	5.2	28.1	23.5	20.4	56.8	53.7	60.0

REMARKS

- 1. *= Measurement does not apply for this frequency.
- 2. Uncertainty in radiated emission measured is <+/-4dB
- 3. Any departure from specification N/A
- 4. Factor will include cable loss and correction factor.
- 5. Sample calculation Emissiom($dB\mu\nu/m$) = Factor (dB) + Ant. Factor (dB/m) + reading $(dB\mu V)$
- 6. Open case





SIGNED BY TESTING ENGINEER



